

<b>Notice of References Cited</b>	Application/Control No. 09/491,142	Applicant(s)/Patent Under Reexamination PHILYAW ET AL.	
	Examiner William C. Vaughn, Jr.	Art Unit 2143	Page 1 of 2

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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
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